

<b>Notice of References Cited</b>	Application/Control No. 09/827,271	Applicant(s)/Patent Under Reexamination MITCHAM ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	J	US-			
	K	US-			
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
<input checked="" type="checkbox"/>	N	WO 9963088 A2	12-1999	World Intellect	BAKER et al.	C12N 15/12
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	N	<del>WO9963088</del>	<del>12-1999</del>	<del>International</del>	<del>Baker et al.</del>	<del>C12N 15/12</del>
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